Search Notes

Application/Control No.	Applicant(s)/Patent unc Reexamination	ler
10/635,133	KRUGER ET AL.	
Examiner	Art Unit	
Stephen J. Kalafut	1745	

SEARCHED				
Class	Subclass	Date	Examiner	
429	99, 152, 153, 156, 158, 159	1/31/2006	SJK	
429	160, 161	1/31/2006	SJK	
429	186, 208	1/31/2006	SJK	
	·			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
			:	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
eDAN Inventor Name Search	1/13/2006	SJK		
· · · · · · · · · · · · · · · · · · ·				